Nature of the metal–insulator transition in oxide interfaces
MICHAEL OSOFSKY, JOSEPH PRESTIGIACOMO, SANDRA HERNNDEZ-HANGARTER, Naval Research Laboratory, ANINDYA NATH, George Mason University, VIRGINIA WHEELER, SCOTT WALTON, RACHEL MYERS-WARD, CLIFFORD KROWNE, KURT GASKILL, KONRAD BUSSMANN, KRISTIN CHARIPAR, CHRISTOPHER CHERVIN, DEBRA ROLISON, Naval Research Laboratory, MICHAEL VEIT, YURI SUZUKI, Stanford University — One of the many unusual properties of several two-dimensional (2D) oxide interface systems (e.g., LaAlO$_3$/SrTiO$_3$) is the presence of a metal–insulator transition (MIT). This feature contradicts the famous prediction of Abrahams, et al. that all two-dimensional systems must be insulating. Since the MIT is a quantum phase transition (one that occurs at T=0K) the transport properties should be independent of the chemical and structural details of the system. Indeed, recent work has demonstrated that a generic phase diagram for the 2D MIT can be constructed for two very different systems: 1) highly disordered RuO$_2$ nanoskins and 2) plasma-functionalized graphene. This phase diagram consists of three regions: metallic, weakly localized insulator with conductivity $\sigma \sim \log T$, and strongly localized insulator. We will present details of the transport properties of the disordered RuO$_2$ nanoskins and plasma-functionalized graphene near their respective MITs. We will then present transport results for several gated oxide interface systems near their MITs and compare them with those for the RuO$_2$ nanoskins and functionalized graphene.

Michael Osofsky
Naval Research Laboratory

Date submitted: 13 Nov 2016